



## P-Channel NexFET™ Power MOSFET

Check for Samples: CSD25303W1015

#### **FEATURES**

- Ultra Low Qg and Qgd
- Small Footprint
- Low Profile 0.62mm Height
- Pb Free
- RoHS Compliant
- Halogen Free
- CSP 1 x 1.5 mm Wafer Level Package

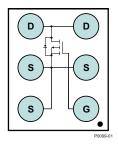
#### **APPLICATIONS**

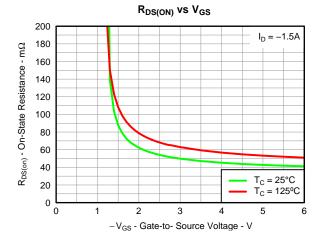
- Battery Management
- Load Switch
- Battery Protection

#### **DESCRIPTION**

The device has been designed to deliver the lowest on resistance and gate charge in the smallest outline possible with excellent thermal characteristics in an ultra low profile.

**Top View** 





#### **PRODUCT SUMMARY**

T <sub>A</sub> = 25°	C unless otherwise stated	TYPICAL VA	UNIT			
$V_{DS}$	Drain to Source Voltage -20					
$Q_g$	Gate Charge Total (4.5V)	3.3	nC			
$Q_{gd}$	Gate Charge Gate to Drain 0.6					
		$V_{GS} = -1.8V$	mΩ			
R <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = -2.5V$	56	mΩ		
		$V_{GS} = -4.5V$	mΩ			
V <sub>GS(th)</sub>	Voltage Threshold	-0.65	V			

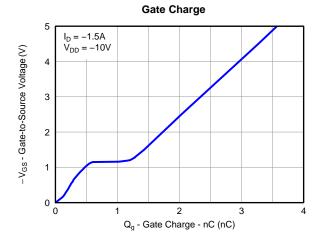
#### ORDERING INFORMATION

Device	Package	Media Qty		Ship	
CSD25303W1015	1 x 1.5 Wafer Level Package	7-inch reel	3000	Tape and Reel	

#### **ABSOLUTE MAXIMUM RATINGS**

T <sub>A</sub> = 2	5°C unless otherwise stated	VALUE	UNIT	
$V_{DS}$	Drain to Source Voltage	-20	٧	
$V_{GS}$	Gate to Source Voltage	±8	V	
$I_D$	Continuous Drain Current, T <sub>C</sub> = 25°C <sup>(1)</sup>	-3	Α	
I <sub>DM</sub>	Pulsed Drain Current, T <sub>A</sub> = 25°C <sup>(2)</sup>	-9	Α	
$P_D$	Power Dissipation <sup>(1)</sup>	1.5	W	
T <sub>STG</sub>	Storage Temperature Range	FF to 150	°C	
T <sub>J</sub> ,	Operating Junction Temperature Range	–55 to 150	٦	

- (1) Typical  $R_{\theta JA} = 90^{\circ} \text{C/W}$  on  $1\text{in}^2$  Cu (2 oz.) on 0.060" thick FR4 PCB.
- (2) Pulse width ≤1ms, duty cycle ≤2%





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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### **ELECTRICAL CHARACTERISTICS**

 $(T_{\Delta} = 25^{\circ}C \text{ unless otherwise stated})$ 

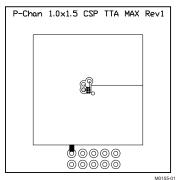
$(1_A = 25^\circ)$	C unless otherwise stated)					
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Ch	naracteristics					
$BV_{DSS}$	Drain to Source Voltage	$V_{GS} = 0V, I_D = -250\mu A$	-20			V
$I_{DSS}$	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = -16V$			-1	μΑ
$I_{GSS}$	Gate to Source Leakage Current	$V_{DS} = 0V$ , $V_{GS} = \pm 8V$			-100	nA
$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-0.65	-1	V
		$V_{GS} = -1.8V, I_D = -1.5A$		72	92	$m\Omega$
R <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = -2.5V, I_D = -1.5A$		56	71	mΩ
		$V_{GS} = -4.5V$ , $I_D = -1.5A$		46	58	mΩ
9 <sub>fs</sub>	Transconductance	$V_{DS} = -10V, I_D = -1.5A$		9.6		S
Dynamic	Characteristics					
C <sub>ISS</sub>	Input Capacitance			335	435	pF
Coss	Output Capacitance	$V_{GS} = 0V, V_{DS} = -10V, f = 1MHz$		149	191	pF
C <sub>RSS</sub>	Reverse Transfer Capacitance			50	65	pF
$R_g$				0.6	1.2	Ω
Qg	Gate Charge Total (-4.5V)			3.3	4.3	nC
$Q_{gd}$	Gate Charge Gate to Drain	$V_{DS} = -10V, I_D = -1.5A$		0.6		nC
$Q_{gs}$	Gate Charge Gate to Source	v <sub>DS</sub> = -10v, i <sub>D</sub> = -1.5A		0.6		nC
Q <sub>g(th)</sub>	Gate Charge at Vth			0.3		nC
Q <sub>OSS</sub>	Output Charge	$V_{DS} = -11V, V_{GS} = 0V$		2.5		nC
t <sub>d(on)</sub>	Turn On Delay Time			3.9		ns
t <sub>r</sub>	Rise Time	$V_{DS} = -10V$ , $V_{GS} = -4.5V$ , $I_{D} = -1.5A$		8.6		ns
$t_{d(off)}$	Turn Off Delay Time	$R_G = 4\Omega$		11.3		ns
t <sub>f</sub>	Fall Time			7.8		ns
Diode Cl	naracteristics					
$V_{SD}$	Diode Forward Voltage	$I_S = -1.5A$ , $V_{GS} = 0V$		-0.72	-1	V
Q <sub>rr</sub>	Reverse Recovery Charge	\/ 11\/ \ 1 = 1 = 0 di/dt = 2000\/		3.6		nC
t <sub>rr</sub>	Reverse Recovery Time	$V_{dd} = -11V$ , $I_F = -1.5A$ , $di/dt = 200A/\mu s$		11.3		ns

## THERMAL CHARACTERISTICS

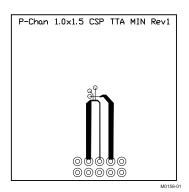
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

		PARAMETER	MIN	TYP	MAX	UNIT
-	Б	Thermal Resistance Junction to Ambient (Minimum Cu area)			198	°C/W
R <sub>θJA</sub>	Thermal Resistance Junction to Ambient (1 in <sup>2</sup> Cu area)			112	°C/W	

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Max  $R_{\theta JA} = 112^{\circ}C/W$  when mounted on 1 inch<sup>2</sup> of 2 oz. Cu.



Max  $R_{\theta JA} = 198^{\circ}C/W$  when mounted on minimum pad area of 2 oz. Cu.

## TYPICAL MOSFET CHARACTERISTICS

(T<sub>A</sub> = 25°C unless otherwise stated)

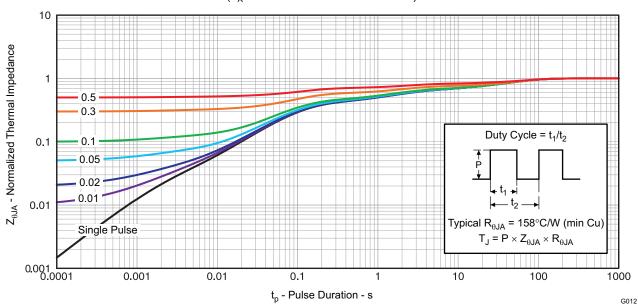


Figure 1. Transient Thermal Impedance

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## TYPICAL MOSFET CHARACTERISTICS (continued)

## $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

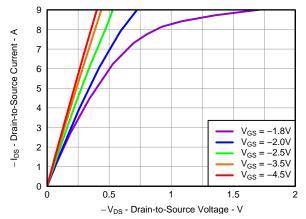


Figure 2. Saturation Characteristics

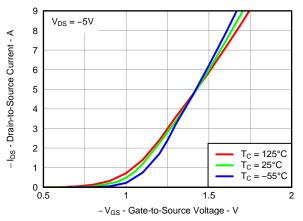


Figure 3. Transfer Characteristics

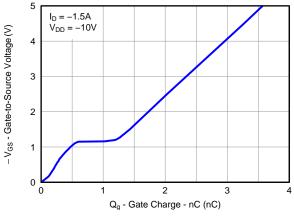


Figure 4. Gate Charge

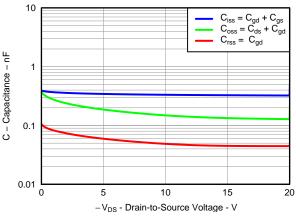


Figure 5. Capacitance

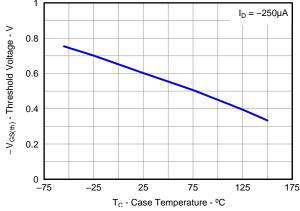


Figure 6. Threshold Voltage vs. Temperature

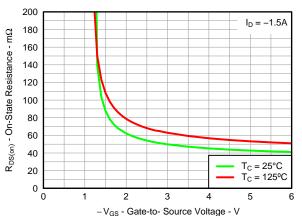


Figure 7. On Resistance vs. Gate Voltage



## **TYPICAL MOSFET CHARACTERISTICS (continued)**

(T<sub>A</sub> = 25°C unless otherwise stated)

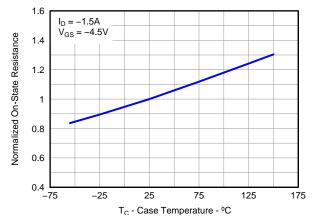


Figure 8. On Resistance vs. Temperature

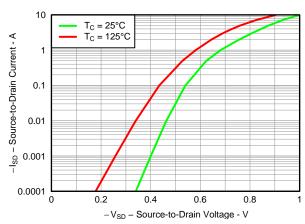


Figure 9. Typical Diode Forward Voltage

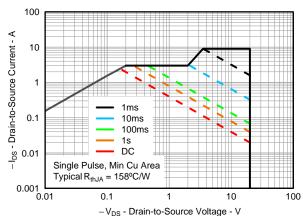


Figure 10. Maximum Safe Operating Area

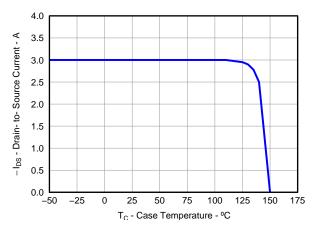


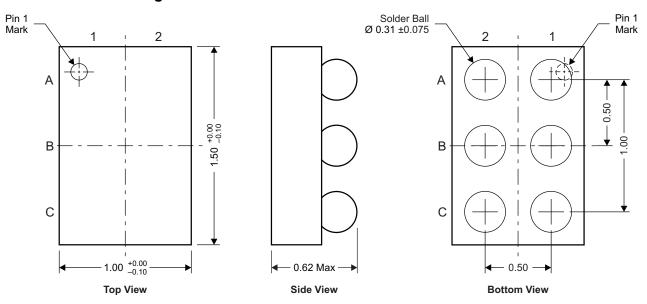
Figure 11. Maximum Drain Current vs. Temperature

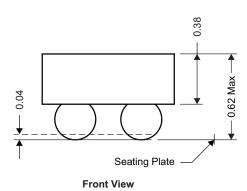
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#### **MECHANICAL DATA**

## CSD25303W1015 Package Dimensions





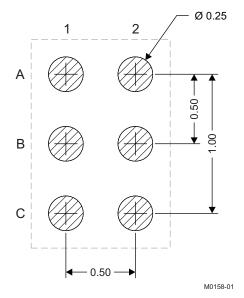
M0157-01

NOTE: All dimensions are in mm (unless otherwise specified)

### **Pinout**

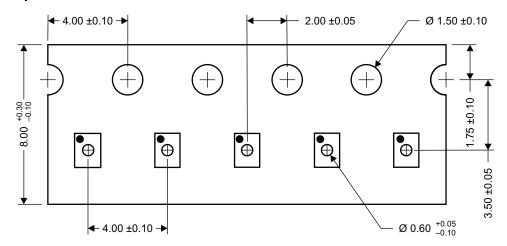
POSITION	DESIGNATION
C1, C2	Drain
A1	Gate
A2, B1, B2	Source

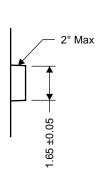
#### **Land Pattern Recommendation**

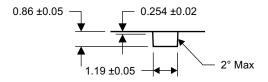


NOTE: All dimensions are in mm (unless otherwise specified)

## **Tape and Reel Information**







M0159-01

NOTE: All dimensions are in mm (unless otherwise specified)



## PACKAGE OPTION ADDENDUM

25-Feb-2014

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD25303W1015	LIFEBUY	DSBGA	YZC	6	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-55 to 150	( )	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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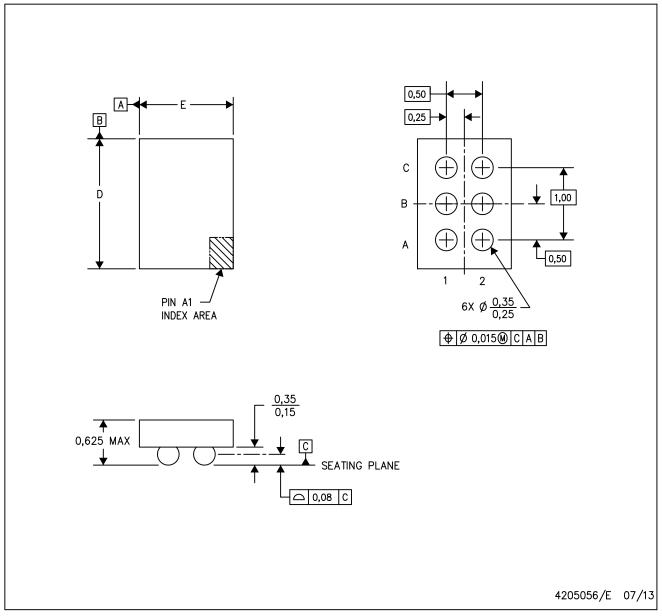




25-Feb-2014

YZC (R-XBGA-N6)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.



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